

<b>Notice of References Cited</b>	Application/Control No. 10/648,644		Applicant(s)/Patent Under Reexamination AARTS ET AL.	
	Examiner Kristin D. Sandoval		Art Unit 2132	Page 1 of 1

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*	B	US-2005/0086061	04-2005	Holtmanns et al.	705/001
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**NON-PATENT DOCUMENTS**

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